Docket No.

215869US0PCT

IN RE APPLICATION OF: Nobuya MATSUOKA, et al.

SERIAL NO: 09/926,641

FILED:

November 28, 2001

FOR:

AGENT FOR EXPRESSION OF LONG-TERM POTENTIATION OF SY

COMPRISING COMPOUND HAVING BRAIN SOMATOSTATIN ACTIVATION PROPERTY

ASSISTANT COMMISSIONER FOR PATENTS WASHINGTON, D.C. 20231

SIR:

Transmitted herewith is an Amendment and Request for Reconsideration w/Marked-up Copy and Substitute Abstract in the aboveidentified application.

☐ No additional fee is required

☐ Small entity status of this application under 37 C.F.R. §1.9 and §1.27 is claimed.

Additional documents filed herewith:

Request for Extension of Time - Three Months

Copy of Date-stamped Filing Receipt dated November 28, 2001 Copy of Date-stamped Filing Receipt dated March 14, 2002

-The Fee has been calculated as shown below:

CLAIMS	CLAIMS REMAINING		HIGHEST NUMBER PREVIOUSLY PAID	NO. EXTRA CLAIMS		RATE		CALCULATIONS
TOTAL	33	MINUS	46	0	х	\$18	=	\$0.00
INDEPENDENT	2	MINUS	6	0	х	\$84	=	\$0.00
		☐ MULTIPL	E DEPENDENT	CLAIMS	+	\$280	#	\$0.00
		TOTAL OF ABOVE CALCULATIONS					\$0.00	
* *,	☐ Reduction by 50% for filing by Small Entity					\$0.00		
12 - 19 ¹ (1) - 5		☐ Recordation of Assignment + \$40 =				=	\$0.00	
						TOT	AL	\$0.00

- A check in the amount of \$930.00 is attached.
- Please charge any additional Fees for the papers being filed herewith and for which no check is enclosed herewith, or credit any overpayment to deposit Account No. 15-0030. A duplicate copy of this sheet is enclosed.
- If these papers are not considered timely filed by the Patent and Trademark Office, then a petition is hereby made under 37 C.F.R. §1.136, and any additional fees required under 37 C.F.R. §1.136 for any necessary extension of time may be charged to Deposit Account No. 15-0030. A duplicate copy of this sheet is enclosed.

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